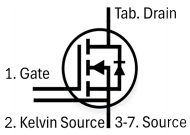
• General Description

This silicon carbide Power MOSFET device has been developed using ZMJ's advanced 1st generation SiC MOSFET technology. The device features a very low RDS(on) over the entire temperature range combined with low capacitances and very high switching operations. It improves application performance in frequency, energy efficiency, system size and weight reduction.

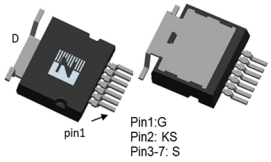
• Product Summary



V_{DS}= 1200V
$R_{DS(ON)}$ = 20mΩ
I_D= 90A

• Features

■High Blocking Voltage
■High Speed Switching With Low Capacitances
■Low $R_{DS(ON)}$ to Minimize Conductive Loss
■Low Gate Charge For Fast Switching
■Low Thermal Resistance
■100% Avalanche Tested
■AEC-Q101 Qualified



T2PAK

•Application

■Motor Drives
■On Board Charger
■DC-DC
■Auxiliary Drives

•Ordering Information:

Part NO.	ZMCA020R120T2
Marking	ZMC020R120
Packing Information	REEL TAPE
Basic ordering unit (pcs)	700

•Absolute Maximum Ratings (T_A=25°C,unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Max.	Unit
Drain-Source Voltage	V_{DS}		-	1200	V
Gate-Source Voltage①	V_{GS}	Transient Voltage	-10	25	V
	V_{GS}	Static Voltage	-10	24	V
Recommended turn on gate voltage	$V_{GS(on)}$		15	18	V
Recommended turn off gate voltage	$V_{GS(off)}$		-4	0	V
Continuous Drain Current	I_D	V_{GS}=18V,T_C=25°C	-	90	A
	I_D	V_{GS}=18V,T_C=75°C	-	74	A
	I_D	V_{GS}=18V,T_C=100°C	-	64	A
Pulsed Drain Current ①	I_{DM}	Pulsed; t_p ≤ 10 μs; T_C = 25 °C;	-	360	A
Total Power Dissipation	P_D	T_C=25℃	-	375	W
Total Power Dissipation	P_D	T_A=25℃	-	3.0	W
Operating Junction Temperature	T_J		-55	175	℃
Storage Temperature	T_{STG}		-55	175	℃
Single Pulse Avalanche Energy	E_{AS}	L=0.5mH, V_{GS}=18V, Rg=25Ω,	-	1225	mJ
ESD Level (HBM)	CLASS 2				

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-	0.4	°C/W
Thermal resistance, junction-ambient	R_{thJA} ②	-	-	50	°C/W
Soldering temperature	Tsold	-	-	260	°C

•Electronic Characteristics (Tj=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} =0V, I_D =250uA	1200	-	-	V
Gate Threshold Voltage	$VGS_{(TH)}$	V_{GS}=V_{DS}, I_D=5mA	2	2.8	4	V
Drain-Source Leakage Current	I_{DSS}	V_{GS}=0V, V_{DS}=1200V	-	-	10	uA
Gate- Source Leakage Current	I_{GSS}	V_{GS}=-10V, V_{DS} =0V	-	-	-100	nA
	I_{GSS}	V_{GS}=25V, V_{DS} =0V	-	-	100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	V_{GS}=18V, I_D=60A, Tj=25°C	-	20	24	mΩ
		V_{GS}=18V, I_D=60A, Tj=175°C	-	38.3	-	mΩ
		V_{GS}=15V, I_D=60A, Tj=25°C	-	26	-	mΩ
Forward Transconductance	g_{FS}	V_{DS} =10V, I_{SD} =60A	-	17	-	S
Diode Forward Voltage	V_{FSD}	V_{GS} =-4V,I_{SD} =60A	-	4.2	5	V

•Dynamic characteristics (Tj=25°C,unless otherwise specified)

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	Ciss	f = 100KHz, V_{DS}=800V, V_{GS}=0V	-	4553	-	pF
Output capacitance	Coss		-	191	-	
Reverse transfer capacitance	Crss		-	9	-	
Output Charge	Q_{oss}	f = 100KHz,V_{GS}=0V, V_{DS}=0V to 800V	-	269	-	nC
Coss Stored Energy	E_{oss}		-	71	-	uJ
Gate Risistance	Rg	f = 1MHz	-	1.6	-	Ω
Total gate charge	Qg	V_{DD} = 800V,I_D = 60A, V_{GS} = -4V/18V	-	184.0	-	nC
Gate - Source charge	Qgs		-	54.8	-	
Gate - Drain charge	Qgd		-	63.8	-	
Turn-ON Delay time	$t_{D(on)}$	V_{GS}=-4V/18V,V_{DS}=800V,R_G =1Ω, I_D =60A	-	20	-	ns
Turn-ON Rise time	t_r		-	8	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	45	-	ns
Turn-Off Fall time	t_f		-	20	-	ns
Turn-On Energy	Eon		-	465	-	uJ
Turn-Off Energy	Eoff		-	138	-	uJ
Reverse Recovery Time	t_{rr}	V_{DD}=100V, dI_S/dt = 100A/us, I_S=60A	-	15	-	ns
Reverse Recovery Charge	Q_{rr}		-	198	-	nC

Fig.1 Gate-source voltage as a function of gate charge;Typical values;Tj=25°C

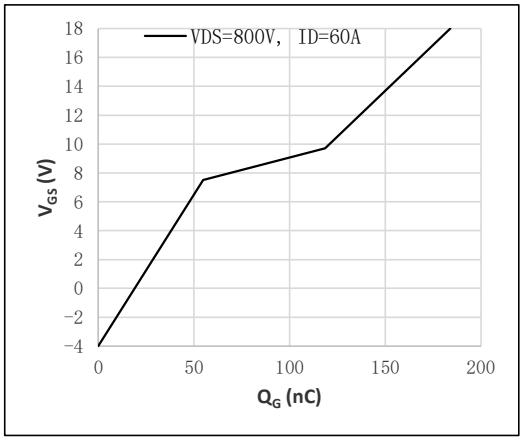


Fig.2 Input, output and reverse transfer capacitances as a function of drain-source voltage;Typical values;Tj=25°C

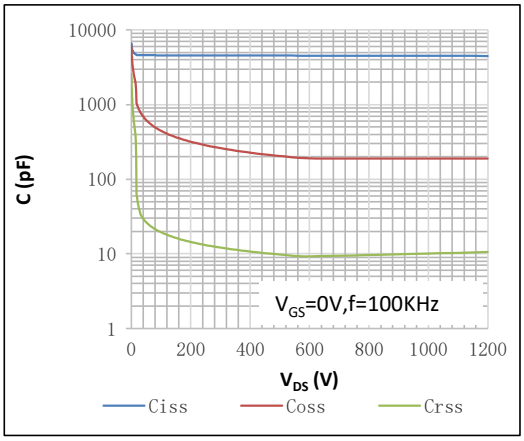


Fig.3 Output characteristics: drain current as a function of drain-source voltage;Typical values; Tj=25°C

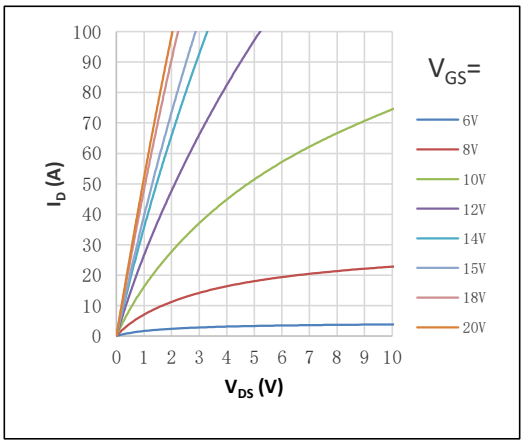


Fig.4 Output characteristics: drain current as a function of drain-source voltage;Typical values:Expanded curve;Tj=25°C

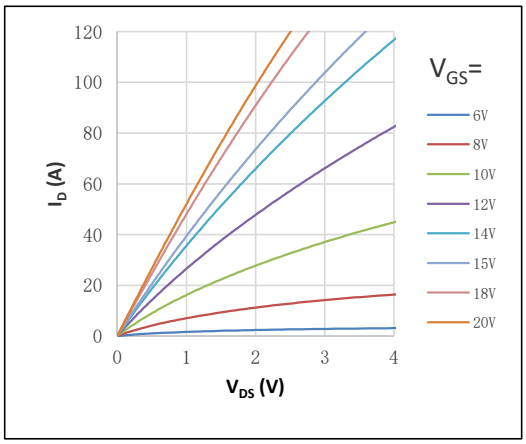


Fig.5 Gate-source threshold voltage as a function of junction temperature;Typical values

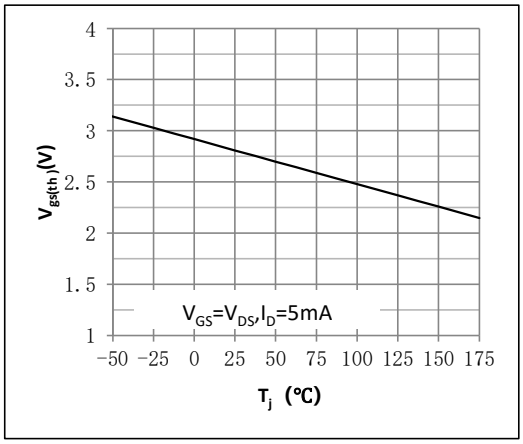


Fig.6 Drain-source on-state resistance as a function of drain current;Typical values;Tj=25°C

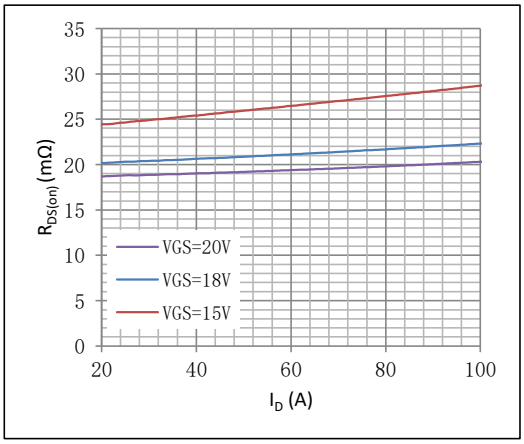


Fig.7 Drain-source on-state resistance as a function of gate-source voltage;Typical values

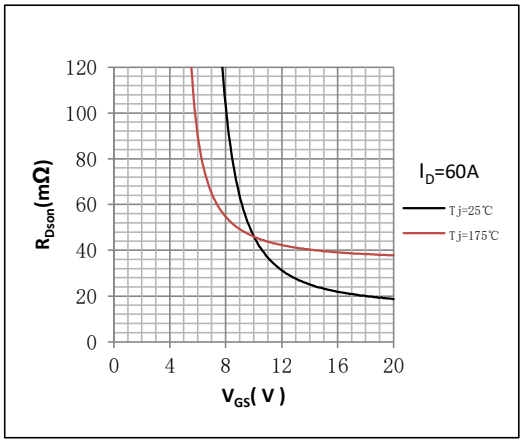


Figure 9. Source (diode forward) current as a function of source-drain (diode forward) voltage ;Typical values

Fig.8 Normalized drain-source on-state resistance factor as a function of junction temperature;Typical values
Normalized On-Resistance=RDSon/RDSon(25℃)

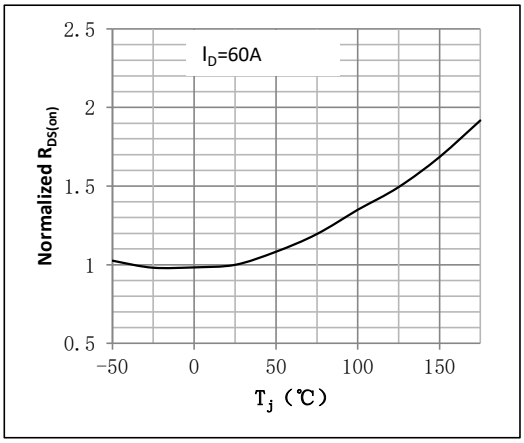


Figure 10. Transfer characteristics: drain current as a function of gate-source voltage;Typical values

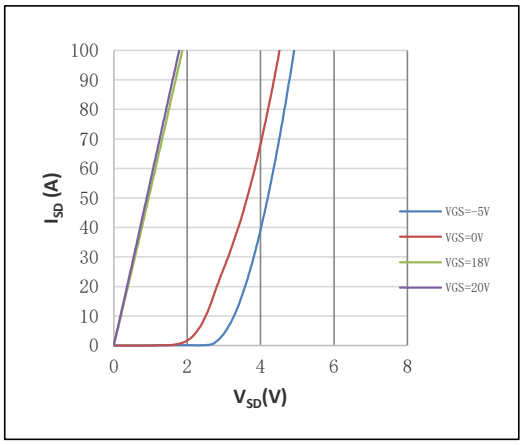


Fig.11 Safe operating area: continuous and peak drain currents as a function of drain-source voltage;Calculative values

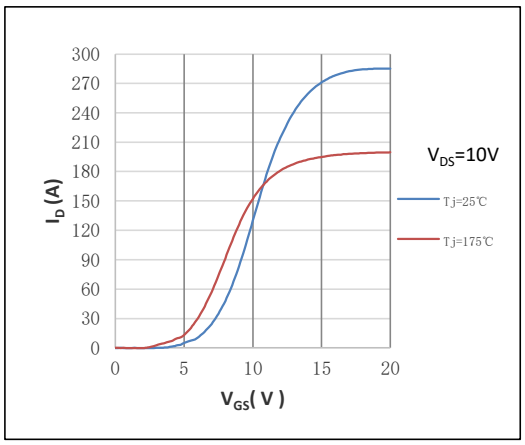
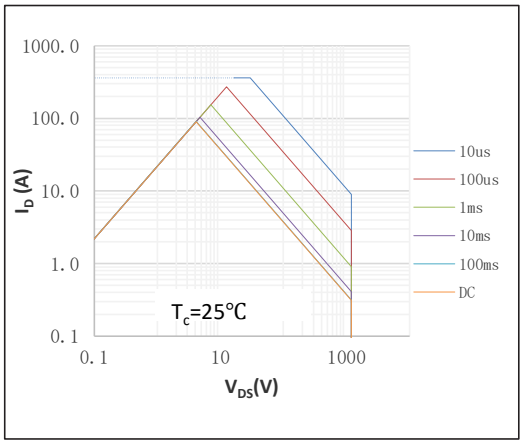


Fig.12 Continuous drain current as a function of case temperature[3];Calculative values



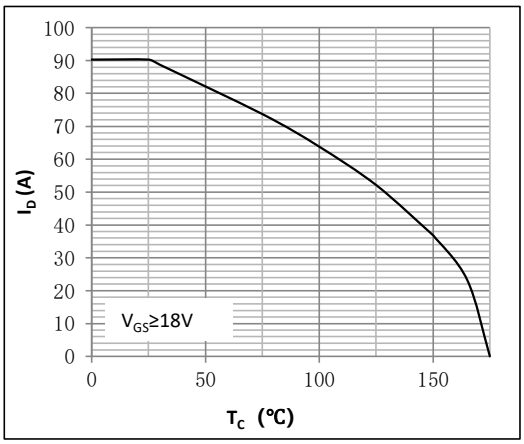


Fig.13 Drain-source breakdown voltage as a function of junction temperature;Typical values
Normalized BVDSS=BVDSS/BVDSS(25°C)

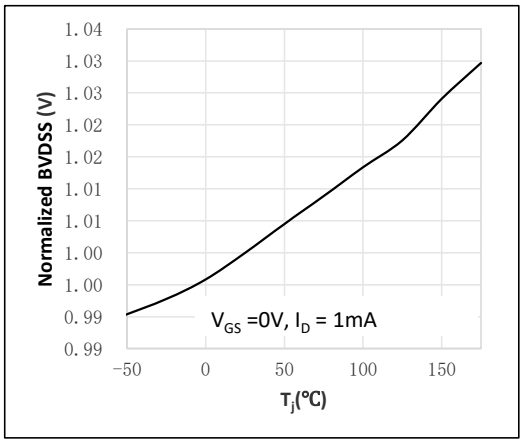


Fig.14 Normalized total power dissipation as a function of case temperature;Calculative values
Normalized Power Dissipation=Pd/Pd(25°C)

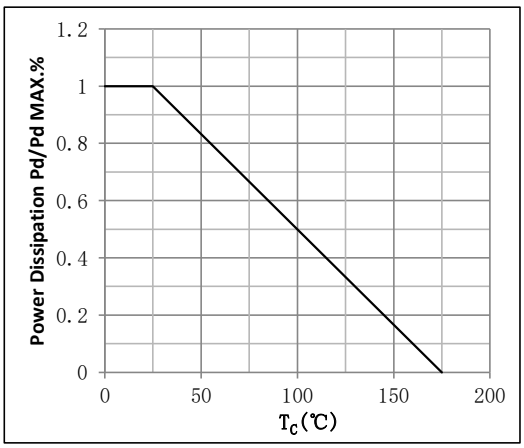


Fig.15 Transient thermal impedance from junction to case as a function of pulse duration; max values

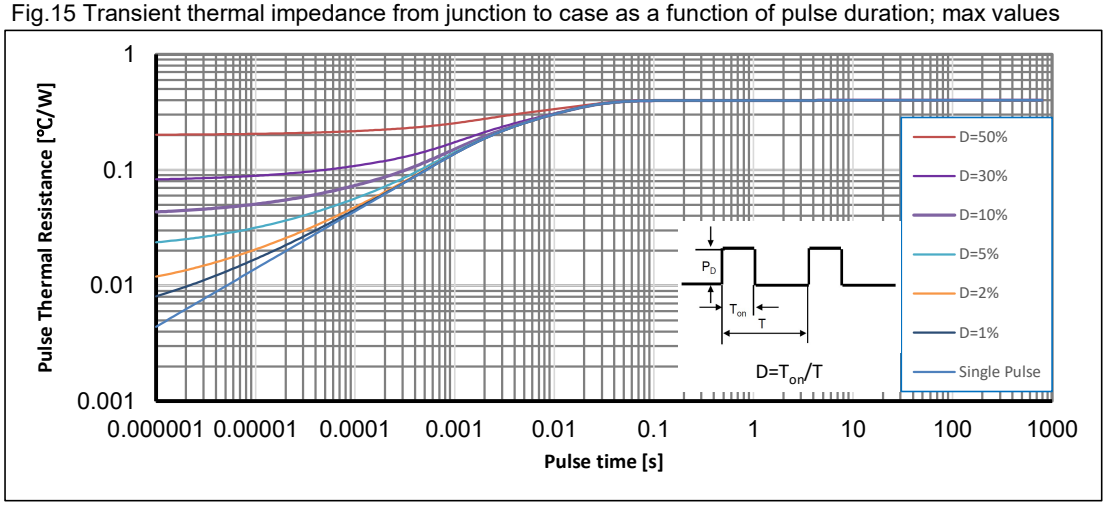
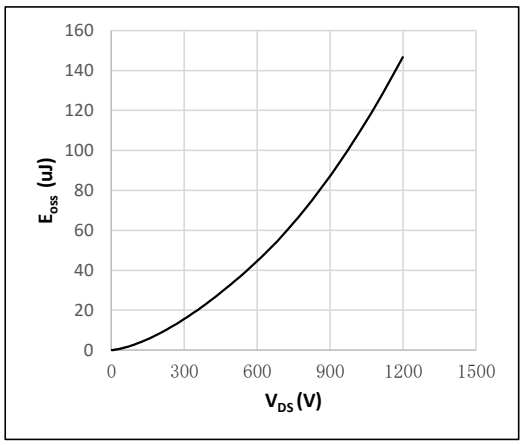
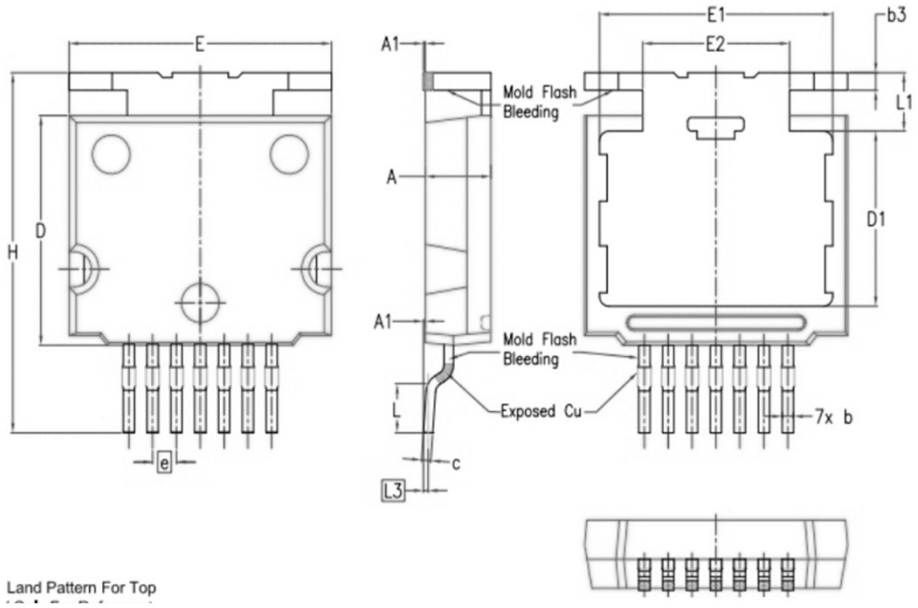


Fig.16 Output capacitor stored energy as a function of drain-source voltage;Typical values;
Tj=25°C



●T2PAK Package Outline



Land Pattern For Top

SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	3.40	3.50	3.60
A1	0.00	0.10	0.25
b	0.50	0.60	0.70
b3	0.80	0.90	1.00
c	0.40	0.50	0.60
c2	0.40	0.50	0.60
D	11.70	11.80	11.90
D1	8.80	9.00	9.10
E	13.90	14.00	14.10
E1	12.30	12.40	12.50
E2	7.75	7.80	7.85
e	1.27 BSC		
H	18.00	18.50	19.00
L	2.30	2.50	2.75
L1	—	3.05	—
L3	—	0.26	—
L5	1.70	1.90	2.15

Note:

① The value of RθJA is measured with the device in a still environment with TA=25℃

②Practically the current will be limited by PCB, thermal design and operating temperature. VGS=18V.

Disclaimer

● Reproducing and modifying information of the document is prohibited without permission from ZMJ SEMICONDDUCTORS CO.,LTD.

● ZMJ SEMICONDDUCTORS CO.,LTD. reserves the rights to make changes of the content herein the document anytime without notification. Please refer to our website for the latest document.

● ZMJ SEMICONDDUCTORS CO.,LTD. disclaims any and all liability arising out of the application or use of any product including damages incidentally and consequentially occurred.

● ZMJ SEMICONDDUCTORS CO.,LTD. does not assume any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

● Applications shown on the herein document are examples of standard use and operation. Customers are responsible in comprehending the suitable use in particular applications. ZMJ SEMICONDDUCTORS CO.,LTD. makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

● The products shown herein are not designed and authorized for equipments relating to human life and for any applications concerning life-saving or life-sustaining, such as medical instruments, aerospace machinery et cetera. Customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify ZMJ SEMICONDDUCTORS CO.,LTD. for any damages resulting from such improper use or sale.

● Since ZMJ uses lot number as the tracking base, please provide the lot number for tracking when complaining.

Version	Date	Change
A	2025/4/16	New